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# N-Channel 100 V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	$R_{DS(on)}$ (m $\Omega$ ) TYP.	$_{\text{in)}}$ (m $\Omega$ ) TYP. $\qquad \qquad \qquad$			
100	1.1 at V <sub>GS</sub> = 10 V	320	183 nC		

#### **FEATURES**

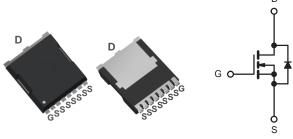
- DT-Trench Power MOSFET
- 100 % R<sub>g</sub> and UIS tested



### **APPLICATIONS**

- Power supplies:
  - Uninterruptible power supplies
  - AC/DC switch-mode power supplies
  - Lighting
- Synchronous rectification
- DC/DC converter
- Motor drive switch
- DC/AC inverter
- Battery management





N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V <sub>DS</sub>	100	V	
Gate-Source Voltage		V <sub>GS</sub>	± 20	v	
Continue Dunio Comment /T 150 °C)	T <sub>C</sub> = 25 °C		320		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>C</sub> = 100 °C	I <sub>D</sub>	205		
Pulsed Drain Current (t = 100 μs)		I <sub>DM</sub>	1280	A	
Avalanche Current	L = 0.1 mH	I <sub>AS</sub>	90		
Single Avalanche Energy <sup>a</sup>	L = U.1 IIIII	E <sub>AS</sub>	3200	mJ	
Maximum Power Dissipation <sup>a</sup>	T <sub>C</sub> = 25 °C	В	490 b	w	
	T <sub>C</sub> = 100 °C	P <sub>D</sub>	4.6 b	v	
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stq</sub>	-55 to +150	°C	

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	LIMIT	UNIT		
Junction-to-Ambient (PCB Mount) <sup>c</sup>	t ≤ 10 s	R <sub>thJA</sub>	12	°C/W		
Junction-to-Case (Drain)	Steady State	R <sub>thJC</sub>	0.26			

#### Notes

- a. Duty cycle  $\leq 1 \%$ .
- b. See SOA curve for voltage derating.
- c. When mounted on 1" square PCB (FR4 material).



PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	100	-	-	V
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2	-	4	
Gate-Body Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$	=	=	± 100	nA
		V <sub>DS</sub> = 100 V, V <sub>GS</sub> = 0 V	-	-	1	μА
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 80 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 85 °C	-	-	30	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> ≥ 10 V, V <sub>GS</sub> = 10 V	320	-	-	Α
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 30 A	-	1.1	1.5	mΩ
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 3 A	-	22	-	S
Dynamic <sup>b</sup>						
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 50 V, f = 1 MHz	-	12300	-	pF
Output Capacitance	C <sub>oss</sub>		-	3290	-	
Reverse Transfer Capacitance	C <sub>rss</sub>		-	42	-	
Total Gate Charge <sup>c</sup>	Qg	V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 100 A	-	183	-	nC
Gate-Source Charge <sup>c</sup>	Q <sub>gs</sub>		-	46	-	
Gate-Drain Charge <sup>c</sup>	Q <sub>gd</sub>		-	52	-	
Gate Resistance	$R_g$	f = 1 MHz	=	2.0	-	Ω
Turn-On Delay Time <sup>c</sup>	t <sub>d(on)</sub>	$V_{DD} = 50 \text{ V}, I_{D} = 100 \text{ A}, R_{g} = 6\Omega$ $V_{GEN} = 10 \text{ V}$	-	42	-	
Rise Time <sup>c</sup>	t <sub>r</sub>		-	55	-	ns
Turn-Off Delay Time <sup>c</sup>	t <sub>d(off)</sub>		-	47	-	
Fall Time <sup>c</sup>	t <sub>f</sub>		-	78	-	
Drain-Source Body Diode Ratings and	Characteristi	ics <sup>b</sup> (T <sub>C</sub> = 25 °C)				
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	-	320	Α
Pulsed Current (t = 100 μs)	I <sub>SM</sub>		-	-	1280	Α
Forward Voltage <sup>a</sup>	V <sub>SD</sub>	I <sub>F</sub> = 1 A, V <sub>GS</sub> = 0 V	-	-	1	V
Reverse Recovery Time	t <sub>rr</sub>	I <sub>F</sub> = 10 A, di/dt = 100 A/µs	-	408	-	ns
Reverse Recovery Charge	Q <sub>rr</sub>	ι <sub>F</sub> = 10 A, αι/αι = 100 Α/μ\$	_	1.6	-	иC

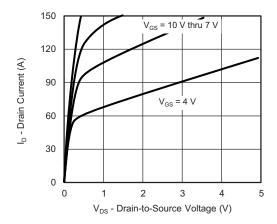
#### Notes

- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.
- c. Independent of operating temperature.

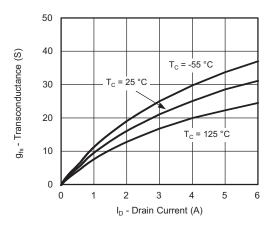
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



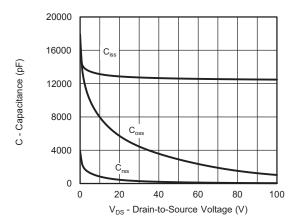
## **TYPICAL CHARACTERISTICS** ( $T_A = 25$ °C, unless otherwise noted)



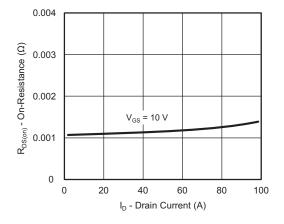
#### **Output Characteristics**



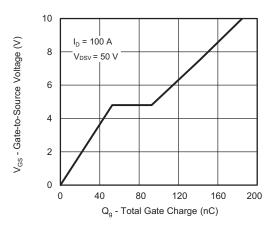
Transconductance



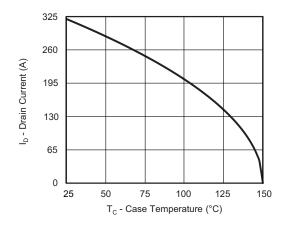
Capacitance



On-Resistance vs. Drain Current



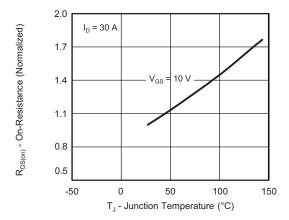
Gate Charge



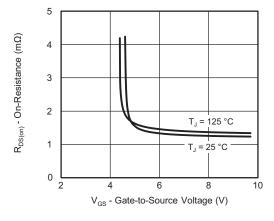
**Current De-Rating** 



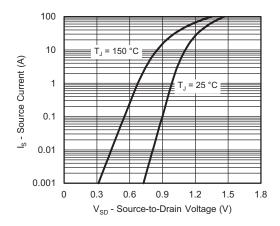
### **TYPICAL CHARACTERISTICS** (T<sub>A</sub> = 25 °C, unless otherwise noted)



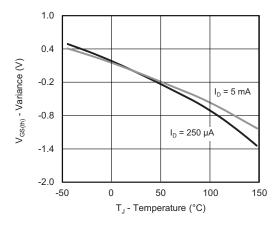
On-Resistance vs. Junction Temperature



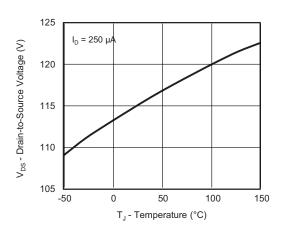
On-Resistance vs. Gate-to-Source Voltage



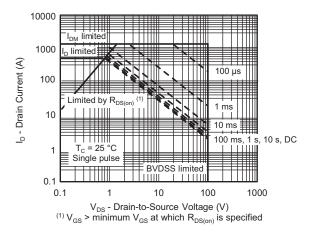
Source Drain Diode Forward Voltage



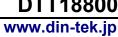
Threshold Voltage



**Drain Source Breakdown vs. Junction Temperature** 

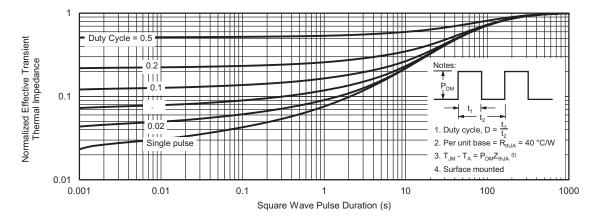


Safe Operating Area



## **THERMAL RATINGS** ( $T_A = 25$ °C, unless otherwise noted)

**Din-Tek** SEMICONDUCTOR



Normalized Thermal Transient Impedance, Junction-to-Ambient





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